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Monday Oct 7, 2019

Keynote Address (8:45PM - 9:45PM)

Chair: Roni Khazaka, McGill University.

Machine Learning and Artificial Neural Networks for High-Speed/High-Frequency Electronic Design.....(see front matter) Q. J. Zhang Chancellor Professor *Carleton University*

SESSION M-I: Advances in Interconnects and High-Speed Links (10:15AM – 11:55AM)

Chairs: Zhonggui Xiang, Huawei Technologies and Kemal Aygun, Intel Corp.

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Korea Advanced Institute of Science and Technology (KAIST)

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Chair: Roni Khazaka, McGill University.

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Georgia Inst. of Technology

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¹BMS College of Engineering, Bangalore ²Indian Institute of Science, Bangalore, ³Intel Technology India Pvt. Ltd

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